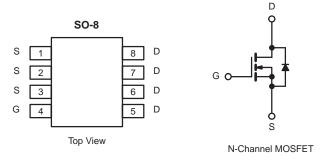


BSO200N03S-VB Datasheet

N-Channel 30-V (D-S) MOSFET

| PRODUCT SUMMARY | | | | | | |
|---------------------|----------------------------------|---------------------------------|-----------------------|--|--|--|
| V _{DS} (V) | $R_{DS(on)}\left(\Omega\right)$ | I _D (A) ^a | Q _g (Typ.) | | | |
| 30 | 0.016 at V _{GS} = 10 V | 6.8 | 9.2 nC | | | |
| 30 | 0.029 at V _{GS} = 4.5 V | 5.8 | 9.2110 | | | |



FEATURES

- Halogen-free According to IEC 61249-2-21 Definition
- Trench Power MOSFET
- Compliant to RoHS Directive 2002/95/EC

Pb-free BoHS

ROHS COMPLIANT HALOGEN FREE

APPLICATIONS

- · Notebook Load Switch
- Low Current dc-to-dc

| Parameter | Symbol | Limit | Unit | |
|---|-----------------------------------|----------------|---------------------|----|
| Drain-Source Voltage | V _{DS} | 30 | V | |
| Gate-Source Voltage | V_{GS} | ± 20 | v | |
| | T _C = 25 °C | | 6.8 ^a | |
| Continuous Drain Current (T _{.1} = 150 °C) | T _C = 70 °C | | 5 ^a | |
| Continuous Diain Curient (1) = 130 °C) | T _A = 25 °C | l D | 6.5 ^{b,c} | |
| | T _A = 70 °C | | 4.9 ^{b,c} | Α |
| Pulsed Drain Current | I _{DM} | 30 | | |
| Continuous Course Drain Diade Current | T _C = 25 °C | | 2.7 | |
| Continuous Source-Drain Diode Current | T _A = 25 °C | I _S | 1.7 ^{b,c} | |
| | T _C = 25 °C | | 4.1 | |
| Manianum Danian Disain ation | T _C = 70 °C | | 2.6 | w |
| Maximum Power Dissipation | T _A = 25 °C | P _D | 2 ^{b,c} | vv |
| | T _A = 70 °C | 1 - | 1.25 ^{b,c} | |
| Operating Junction and Storage Temperature Rang | T _J , T _{stq} | - 55 to 150 | °C | |

| THERMAL RESISTANCE RATINGS | | | | | | |
|---|--------------|-------------------|---------|---------|------|--|
| Parameter | | Symbol | Typical | Maximum | Unit | |
| Maximum Junction-to-Ambient ^{b, d} | t ≤ 5 s | R _{thJA} | 45 | 62.5 | °C/W | |
| Maximum Junction-to-Foot | Steady State | R _{thJF} | 25 | 30 | C/VV | |

Notes

- a. Package Limited.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 5 s
- d. Maximum under Steady State conditions is 110 °C/W.



| Parameter | Symbol | Test Conditions | Min. | Тур. | Max. | Unit | |
|---|-------------------------|--|-------|-------|-------|--------|--|
| Static | | | | | | | |
| Drain-Source Breakdown Voltage | V_{DS} | $V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$ | 30 | | | V | |
| V _{DS} Temperature Coefficient | $\Delta V_{DS}/T_{J}$ | I _D = 250 μA | | 33 | | m\//0C | |
| V _{GS(th)} Temperature Coefficient | $\Delta V_{GS(th)}/T_J$ | 1 _D = 230 μA | | - 6.2 | | mV/°C | |
| Gate-Source Threshold Voltage | V _{GS(th)} | $V_{DS} = V_{GS}, I_{D} = 250 \mu A$ | 1 | | 3 | V | |
| Gate-Source Leakage | I _{GSS} | $V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$ | | | ± 100 | nA | |
| Zoro Coto Voltago Drain Current | I _{DSS} | $V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$ | | | 1 | | |
| Zero Gate Voltage Drain Current | | $V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$ | | | 10 | μA | |
| On-State Drain Current ^a | I _{D(on)} | $V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$ | 20 | | | Α | |
| Davis Course Co Otata Basista and | D | V _{GS} = 10 V, I _D = 5 A | 0.016 | | | | |
| Drain-Source On-State Resistance ^a | R _{DS(on)} | $V_{GS} = 4.5 \text{ V}, I_D = 4 \text{ A}$ | | 0.029 | | Ω | |
| Forward Transconductance ^a | 9 _{fs} | V _{DS} = 10 V, I _D = 5 A | | 24 | | S | |
| Dynamic ^b | | | | | | • | |
| Input Capacitance | C _{iss} | | | 1295 | | pF | |
| Output Capacitance | C _{oss} | $V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$ | | 170 | | | |
| Reverse Transfer Capacitance | C _{rss} | | | 72 | | | |
| Total Cata Chausa | | $V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 5 \text{ A}$ | | 21.8 | 33 | nC | |
| Total Gate Charge | | | | 9.2 | 14 | | |
| Gate-Source Charge | Q_{gs} | $V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 5 \text{ A}$ | | 3.8 | | | |
| Gate-Drain Charge | Q _{gd} | | | 2.5 | | | |
| Gate Resistance | R_{g} | f = 1 MHz | | 2.4 | | Ω | |
| Turn-On Delay Time | t _{d(on)} | | | 21 | 40 | | |
| Rise Time | t _r | V_{DD} = 15 V, R_L = 3 Ω | | 14 | 25 | | |
| Turn-Off DelayTime | t _{d(off)} | $I_D \cong 5 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$ | | 20 | 40 | | |
| Fall Time | t _f | | | 9 | 18 | | |
| Turn-On Delay Time | t _{d(on)} | | | 10 | 20 | ns | |
| Rise Time | t _r | V_{DD} = 15 V, R_L = 3 Ω | | 8 | 16 | _ | |
| Turn-Off DelayTime | t _{d(off)} | $I_D \cong 5 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$ | | 21 | 35 | | |
| Fall Time | t _f | | | 8 | 16 | | |
| Drain-Source Body Diode Characterist | ics | | | | | | |
| Continous Source-Drain Diode Current | I _S | T _C = 25 °C | | | 2.7 | ۸ | |
| Pulse Diode Forward Current | I _{SM} | | | | 30 | A | |
| Body Diode Voltage | V_{SD} | I _S = 1.7 A, V _{GS} = 0 V | | 0.77 | 1.2 | V | |
| Body Diode Reverse Recovery Time | t _{rr} | | | 21 | 40 | ns | |
| Body Diode Reverse Recovery Charge | | | | 15 | 30 | nC | |
| Reverse Recovery Fall Time | t _a | Ir = 3 A. 01/01 = 100 A/08. I r = 25 G. | | 13 | | | |
| Reverse Recovery Rise Time | | | | 8 | | ns | |

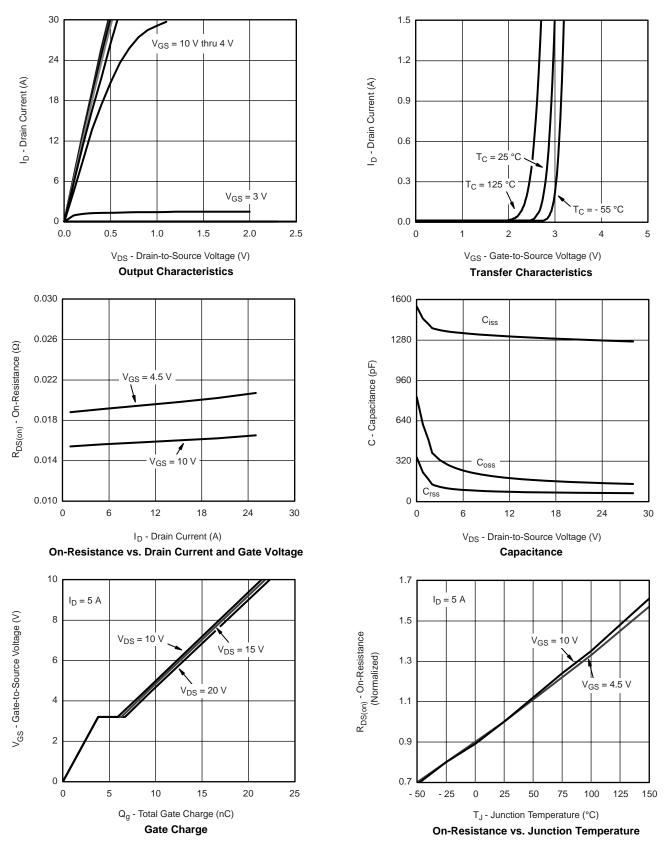
Notes:

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

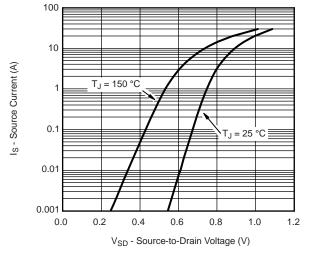
a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$

b. Guaranteed by design, not subject to production testing.

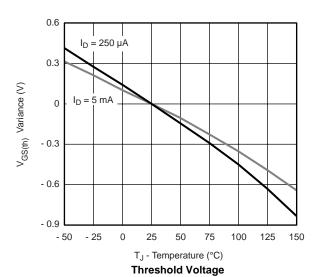


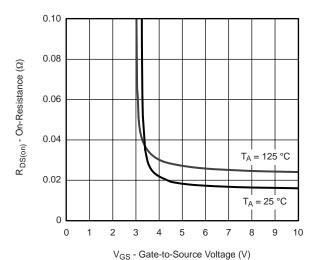




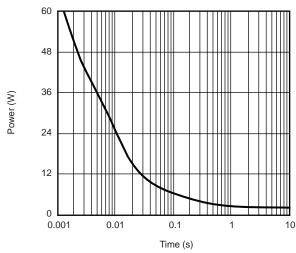


Source-Drain Diode Forward Voltage

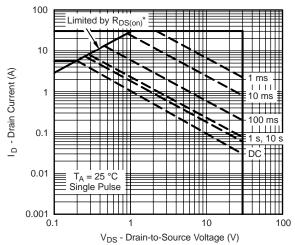




On-Resistance vs. Gate-to-Source Temperature



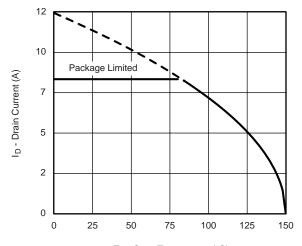
Single Pulse Power, Junction-to-Ambient



 * V_{GS} > minimum V_{GS} at which $R_{DS(on)}$ is specified

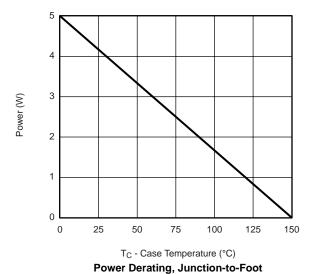
Safe Operating Area, Junction-to-Ambient

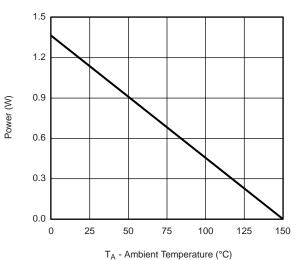




 $T_{\mbox{\scriptsize C}}$ - Case Temperature (°C)

Current Derating*

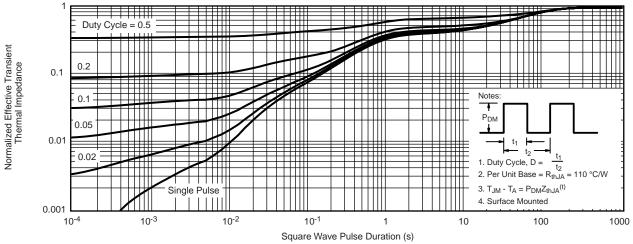




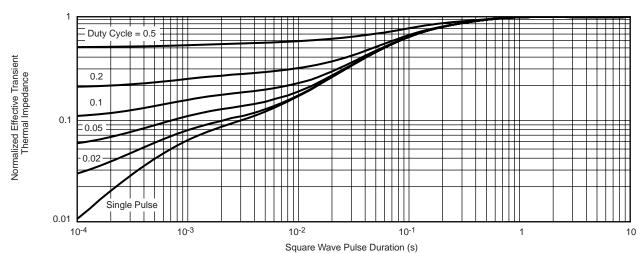
Power Derating, Junction-to-Ambient

^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot



SOIC (NARROW): 8-LEADJEDEC Part Number: MS-012







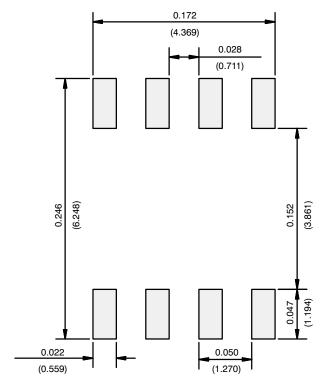
| | MILLIN | IETERS | INCHES | | | |
|------------------------------|--------|-------------------|--------|-------|--|--|
| DIM | Min | Max | Min | Max | | |
| Α | 1.35 | 1.75 | 0.053 | 0.069 | | |
| A ₁ | 0.10 | 0.20 | 0.004 | 0.008 | | |
| В | 0.35 | 0.51 | 0.014 | 0.020 | | |
| С | 0.19 | 0.25 | 0.0075 | 0.010 | | |
| D | 4.80 | 5.00 | 0.189 | 0.196 | | |
| E | 3.80 | 4.00 | 0.150 | 0.157 | | |
| е | 1.27 | 1.27 BSC 0.050 BS | |) BSC | | |
| Н | 5.80 | 6.20 | 0.228 | 0.244 | | |
| h | 0.25 | 0.50 | 0.010 | 0.020 | | |
| L | 0.50 | 0.93 | 0.020 | 0.037 | | |
| q | 0° | 8° | 0° | 8° | | |
| S | 0.44 | 0.64 | 0.018 | 0.026 | | |
| ECN: C-06527-Pay I 11-San-06 | | | | | | |

ECN: C-06527-Rev. I, 11-Sep-06

DWG: 5498



RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)

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